

Notice of References Cited	Application/Control No. 10/578,776		Applicant(s)/Patent Under Reexamination SAKURAI ET AL.	
	Examiner MATTHEW D. MATZEK		Art Unit 1794	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,495,258	12-2002	Chen et al.	428/408
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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